


<b>Search Notes</b>  	<b>Application/Control No.</b>  10537756	<b>Applicant(s)/Patent Under Reexamination</b>  HAYDON, DAVID JOHN
	<b>Examiner</b>  IQBAL H CHOWDHURY	<b>Art Unit</b>  1652

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN- index bioscience medicine- see documentation of record.	4/3/2009	IC
WEST- USPT, PGPB, EPAB, JPAB, DWPI- see documentation of record.	4/3/2009	IC
PALM- inventor search.	4/3/2009	IC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--